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Koivulehto et al.

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(54) **ANALYTICAL TEST INTERPRETATION CARD**

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(58) **Field of Classification Search** D10/52, D10/53, 56; 73/73, 29.02, 29.04; 116/200, 116/207, 216, 217, 219, 201; 374/102, 104, 374/106, 161, 162; 422/55, 61; D24/216, D24/232–231, 107; D19/1, 10; 206/232; 435/33, 36; D20/40; 436/518; D14/36
See application file for complete search history.

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(57) **CLAIM**

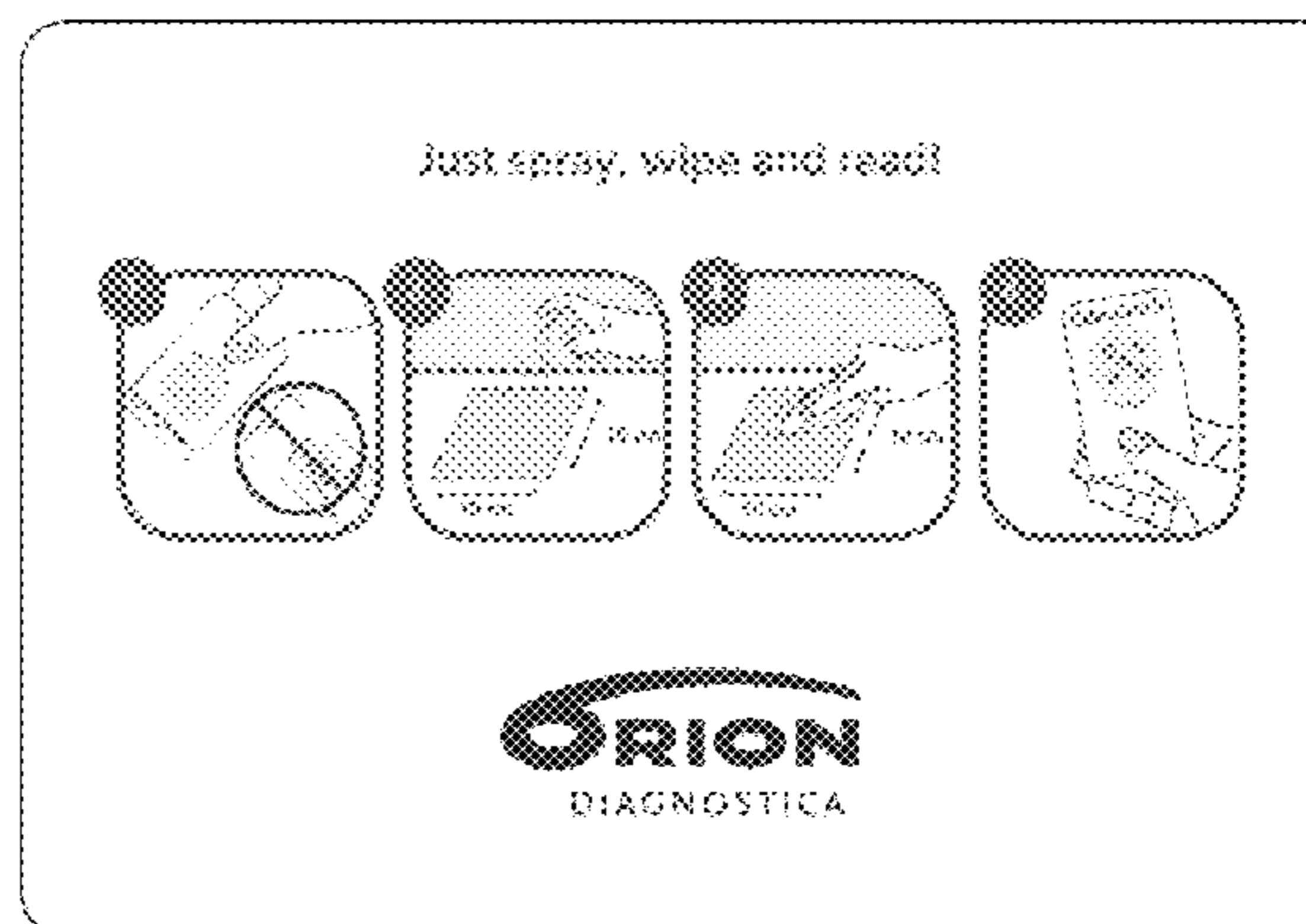
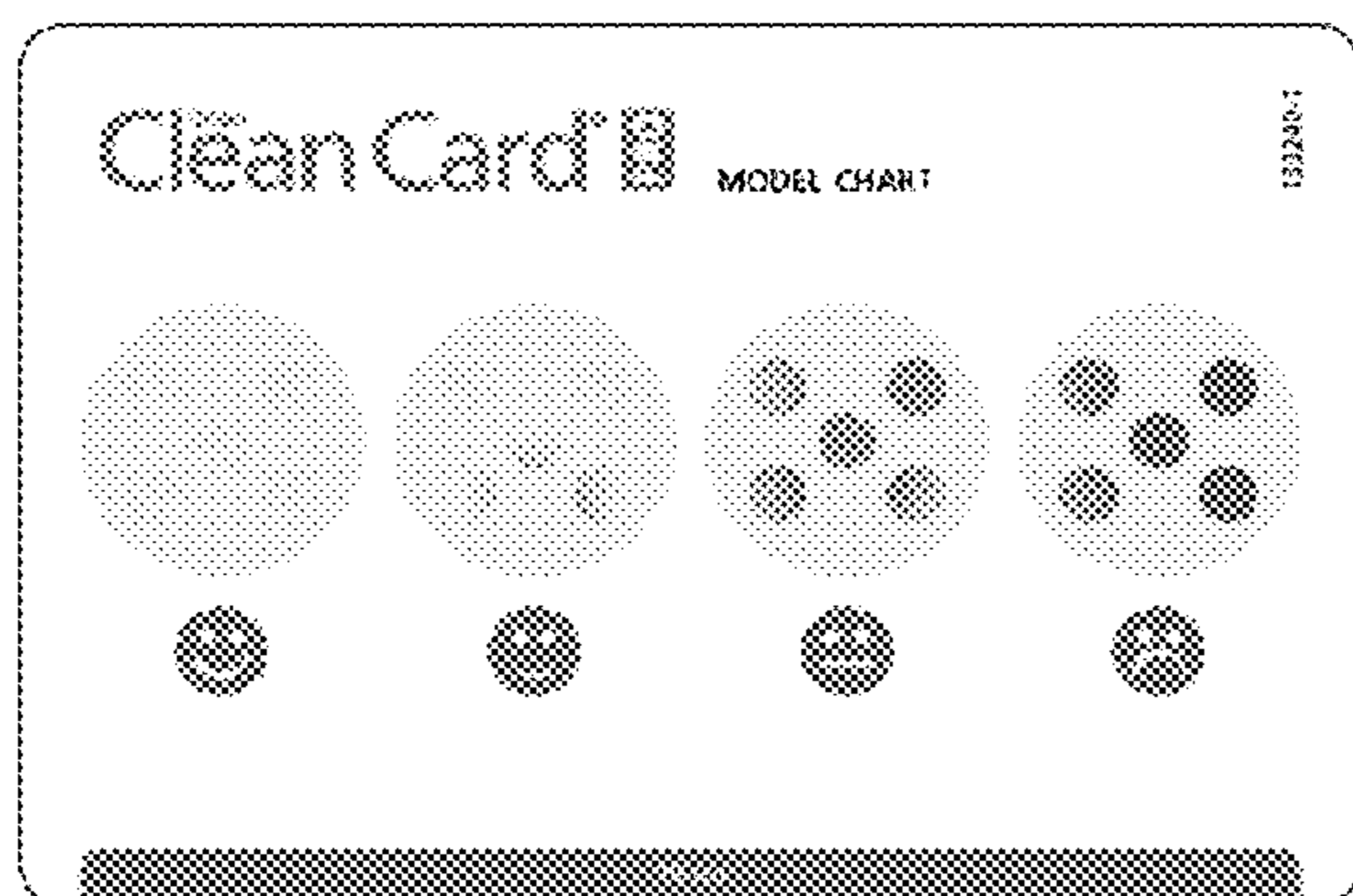
The ornamental design for an analytical test interpretation card, as shown and described.

DESCRIPTION

FIG. 1 is front plan view of a analytical test interpretation card of our new design; and,

FIG. 2 is a rear plan view thereof.

1 Claim, 2 Drawing Sheets



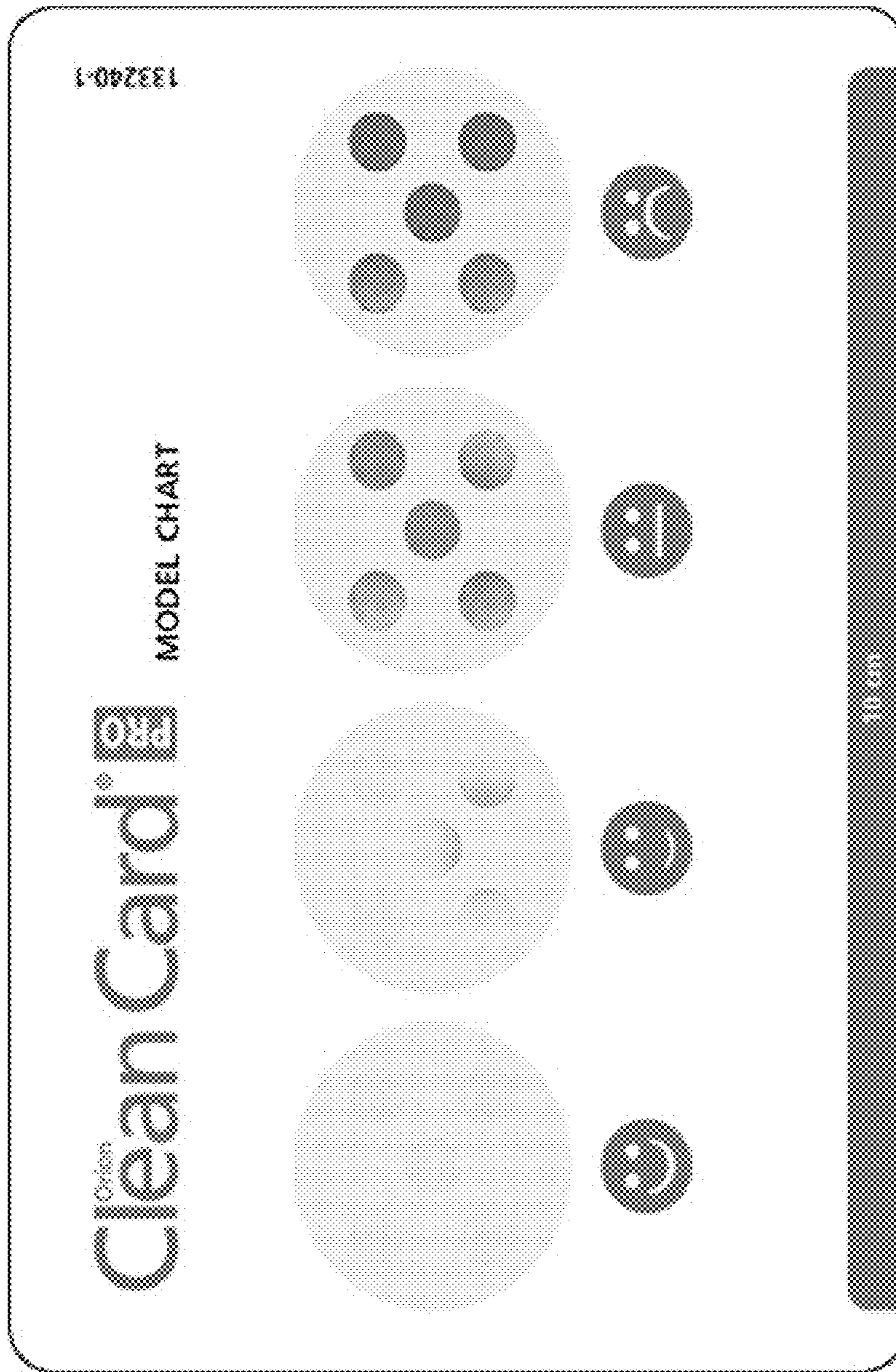


FIG. 1

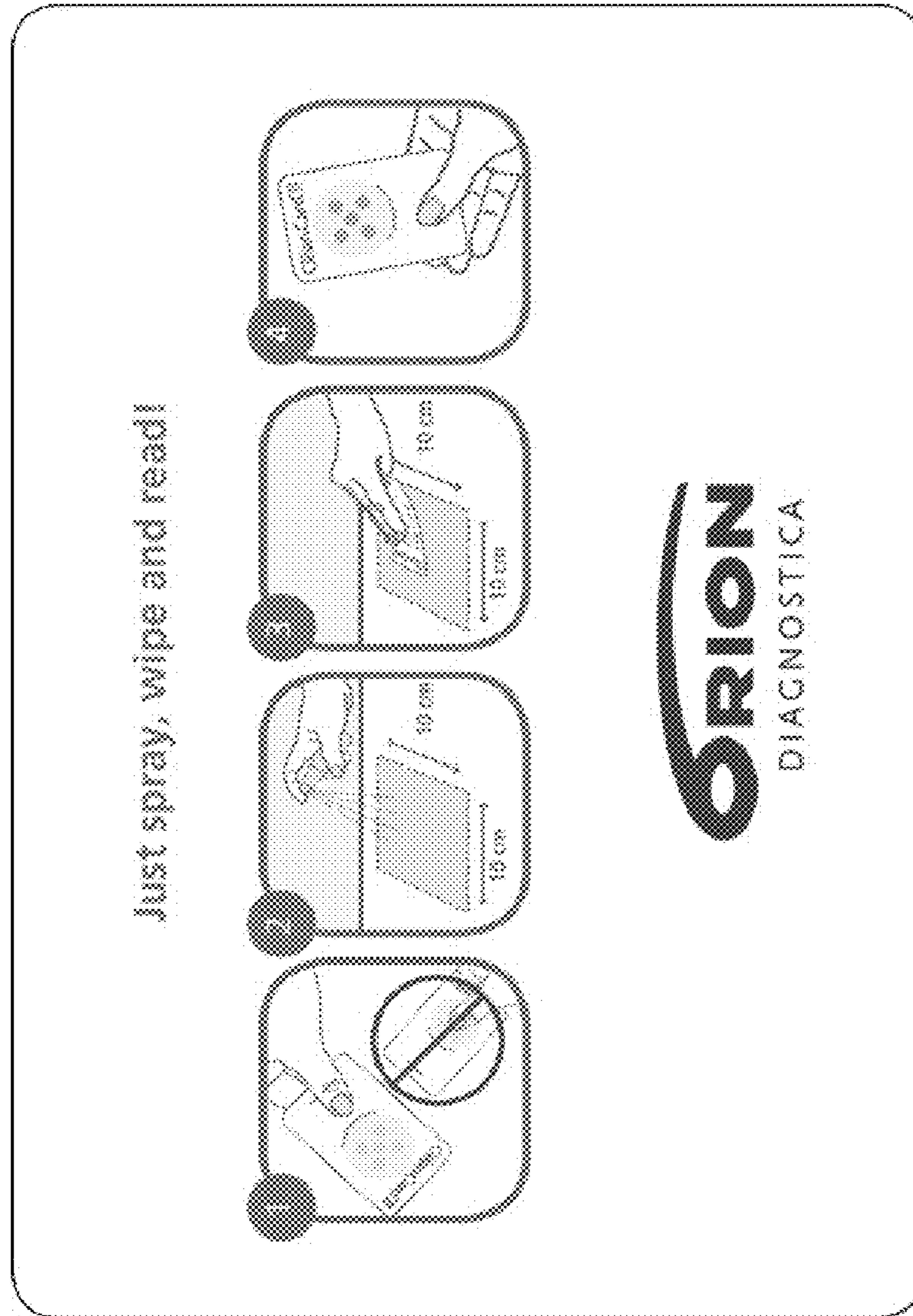


FIG. 2